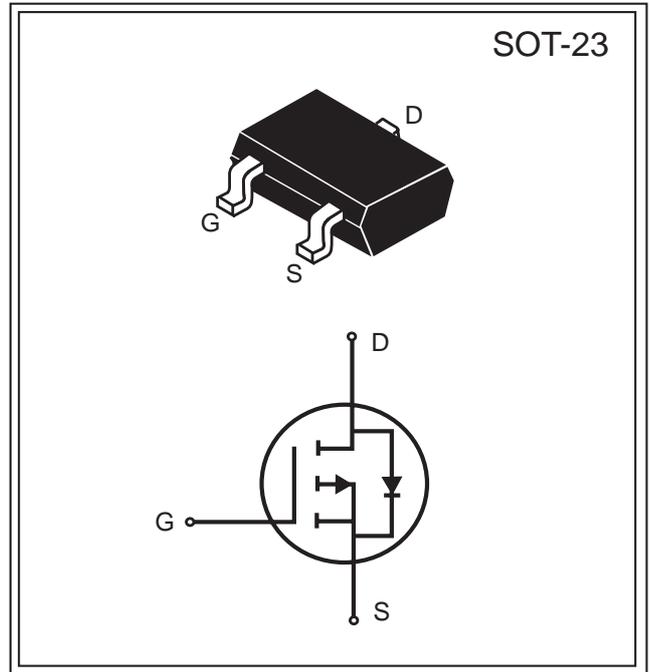




Product Summary		
V _{DS} (V)	I _D (A)	R _{DS(ON)} (mΩ) Max
-20V	-2.3A	130 @V _{GS} = -4.5V
		190 @V _{GS} = -2.5V



FEATURES

- Super high dense cell design for low R_{DS(ON)}.
- Rugged and reliable.
- SOT-23 package.

ABSOLUTE MAXIMUM RATINGS (T_A = 25 °C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	-20	V
Gate-Source Voltage	V _{GS}	±10	V
Drain Current-Continuous @ T _J = 25 °C	I _D	-2.3	A
-Pulsed ^b	I _{DM}	-8	A
Drain-Source Diode Forward Current ^a	I _S	-1.25	A
Maximum Power Dissipation ^a	P _D	1.25	W
Operating Junction and Storage Temperature Range	T _J , T _{STG}	-55 to 150	°C

THERMAL CHARACTERISTICS

Thermal Resistance, Junction-to-Ambient ^a	R _{JA}	100	°C/W
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South Sea Semiconductor reserves the right to make changes to improve reliability or manufacturability without advance notice.

South Sea Semiconductor, August 2005 (Rev 2.0)



Electrical Characteristics (T _A = 25°C unless otherwise noted)						
Parameter	Symbol	Condition	Min	Typ ^c	Max	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =-250 μ A	-20			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =-16V, V _{GS} =0V			1	μ A
Gate-Body Leakage	I _{GSS}	V _{GS} = ± 10V, V _{DS} =0V			± 100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} I _D =-250 μ A	-0.5	-1	-1.5	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =-4.5V, I _D =-2.3A			130	m
		V _{GS} =-2.5V, I _D =-2.0A			190	
On-State Drain Current	I _{D(ON)}	V _{DS} =-5V, V _{GS} =-4.5V	-5			A
Forward Transconductance	g _{FS}	V _{DS} =-5V, I _D =-2A		5		S
Input Capacitance	C _{ISS}	V _{DS} =-15V V _{GS} =0V f=1.0MHz		355		pF
Output Capacitance	C _{OSS}			78		
Reverse Transfer Capacitance	C _{RSS}			37		
Turn-On Delay Time	t _{D(ON)}	V _{DD} =-10V, I _D =-1A, V _{GS} =-4.5V, R _{GEN} =6 Ω, R _L =10 Ω		10		ns
Rise Time	t _r			11		
Turn-Off Delay Time	t _{D(OFF)}			141		
Fall Time	t _f			56		
Total Gate Charge	Q _g	V _{DS} =-10V, I _D =-2.3A, V _{GS} =-4.5V		3.5		nC
Gate-Source Charge	Q _{gs}			0.5		
Gate-Drain Charge	Q _{gd}			1		
Diode Forward Voltage	V _{SD}	V _{GS} =0V, I _D =-1.25A		-0.8	-1.2	V

Notes :

- a. Surface Mounted on FR4 Board, t ≤ 10 sec.
- b. Pulse Test : Pulse Width ≤ 300 μ s, Duty Cycle ≤ 2%.
- c. Guaranteed by design, not subject to production testing.

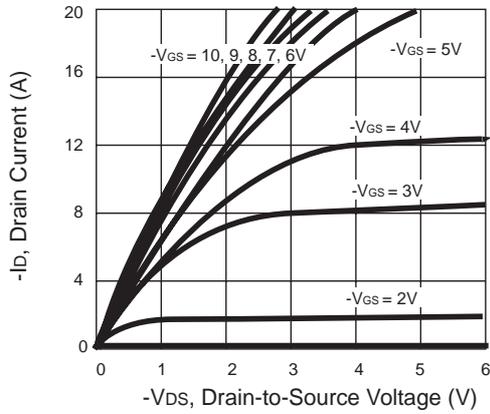


Figure 1. Output Characteristics

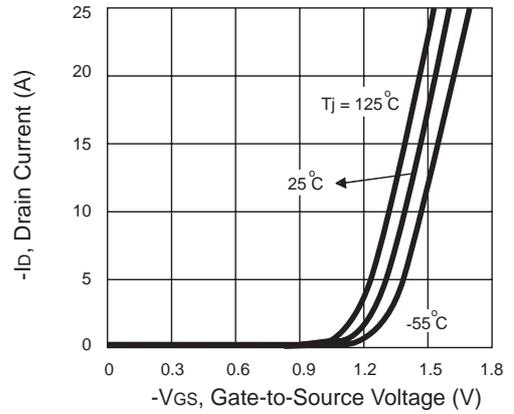


Figure 2. Transfer Characteristics

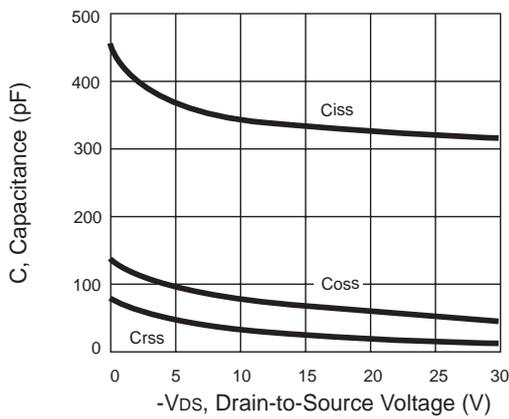


Figure 3. Capacitance

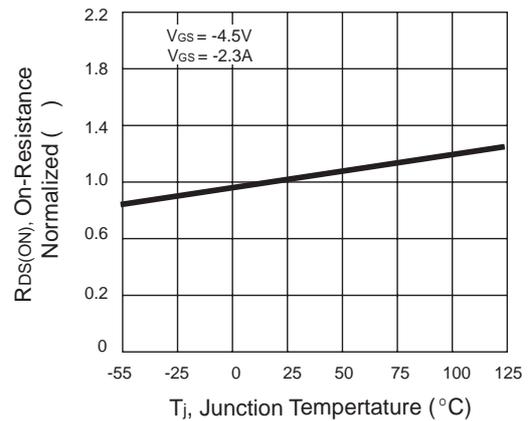


Figure 4. On-Resistance Variation with Temperature

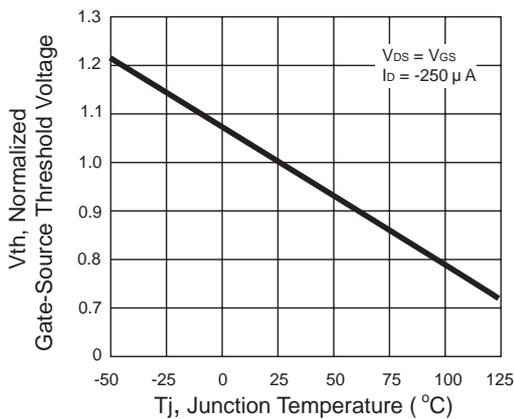


Figure 5. Gate Threshold Variation with Temperature

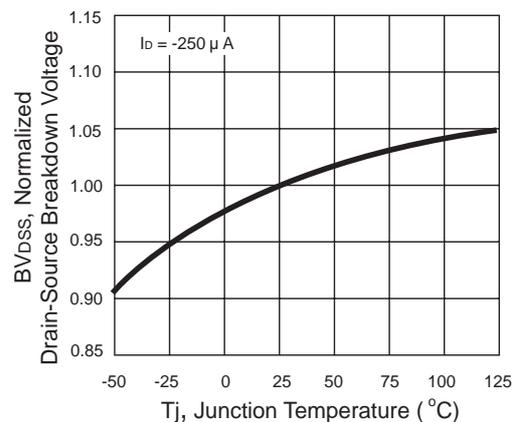


Figure 6. Breakdown Voltage Variation with Temperature

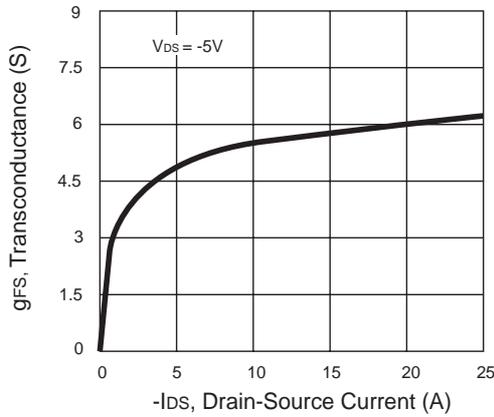


Figure 7. Transconductance Variation with Drain Current

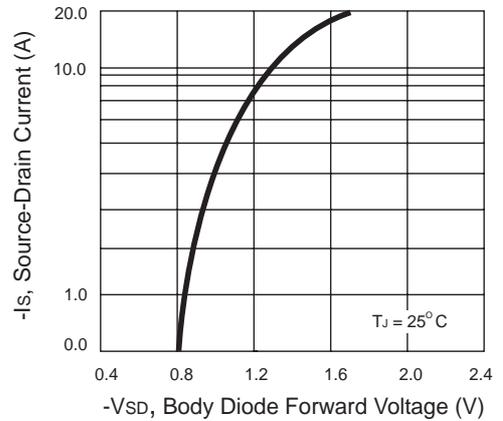


Figure 8. Body Diode Forward Voltage Variation with Source Current

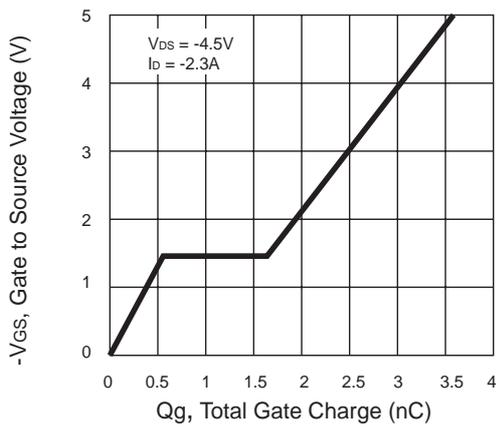


Figure 9. Gate Charge

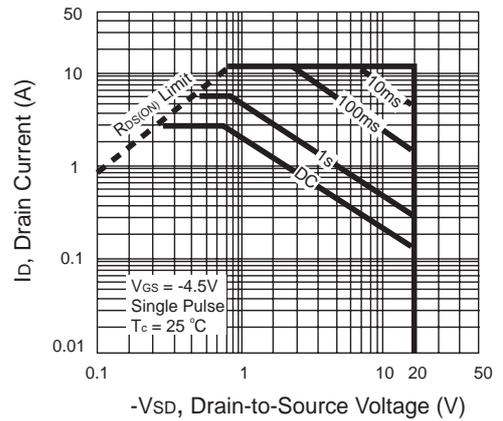


Figure 10. Maximum Safe Operating Area

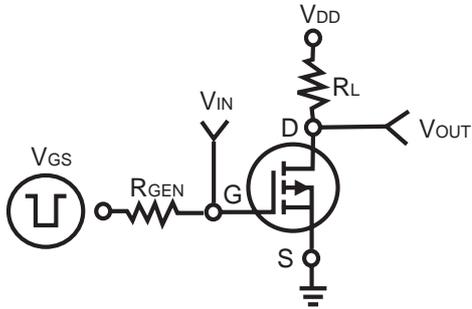


Figure 11. Switching Test Circuit

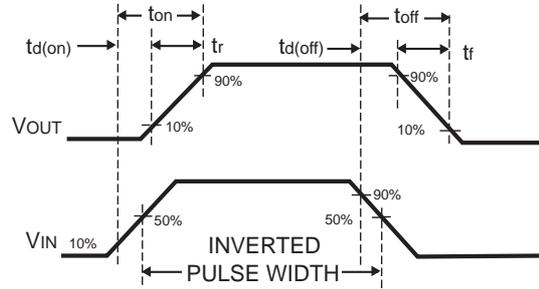


Figure 12. Switching Waveforms

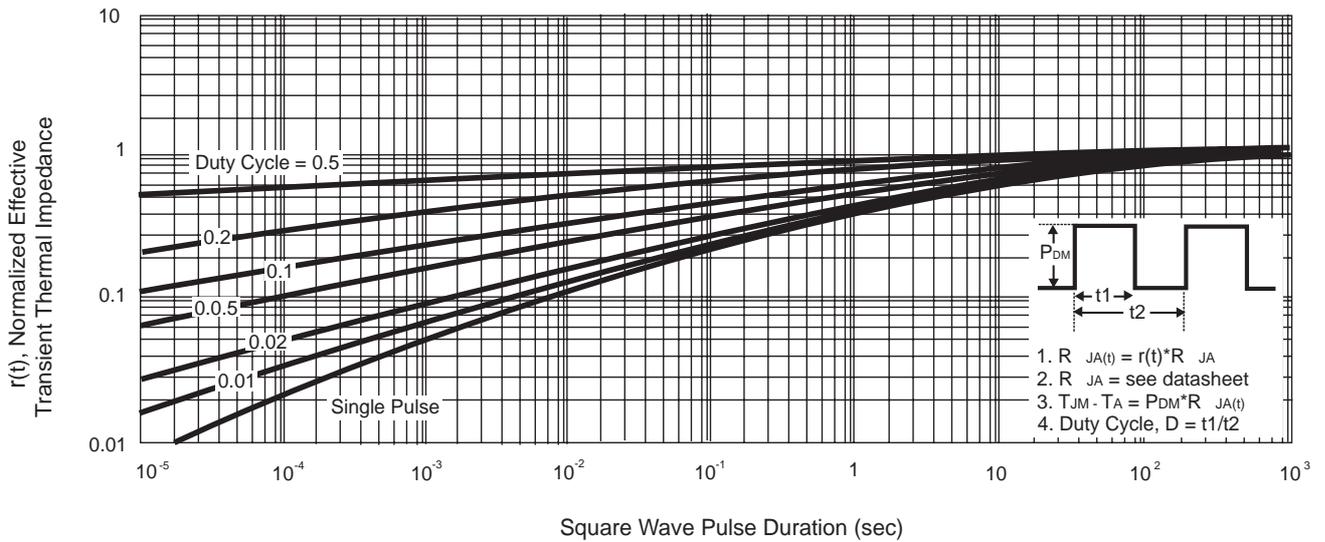
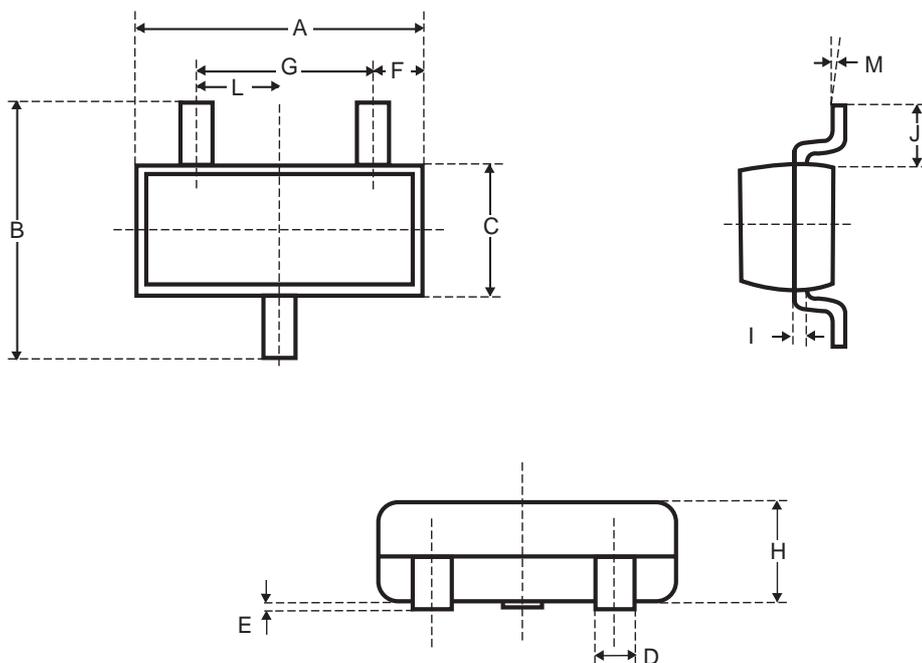


Figure 13. Normalized Thermal Transient Impedance Curve



Package Outline Dimensions

SOT-23

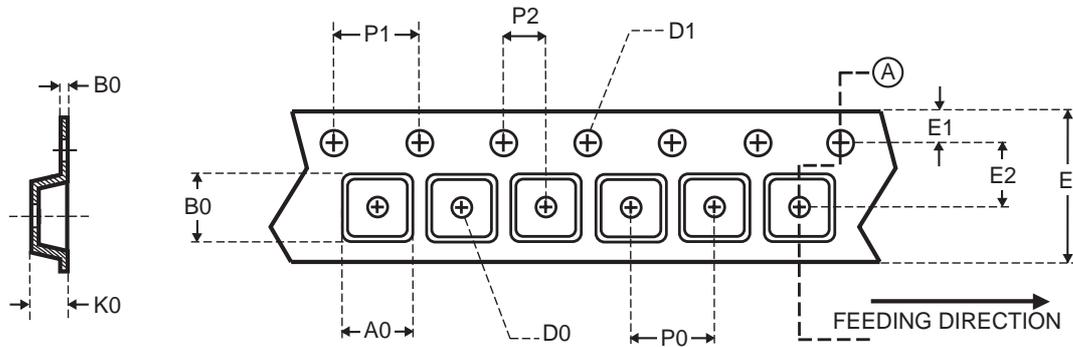


SYMBOLS	MILLIMETERS		INCHES	
	Min.	Max.	Min.	Max.
A	2.70	3.10	0.106	0.122
B	2.40	2.80	0.094	0.110
C	1.40	1.60	0.055	0.063
D	0.35	0.50	0.014	0.020
E	0	0.10	0	0.004
F	0.45	0.55	0.018	0.022
G	1.90 REF.		0.075 REF.	
H	1.00	1.30	0.039	0.051
I	0.10	0.20	0.004	0.008
J	0.40	-	0.016	-
L	0.85	1.15	0.033	0.045
M	0°	10°	0°	10°



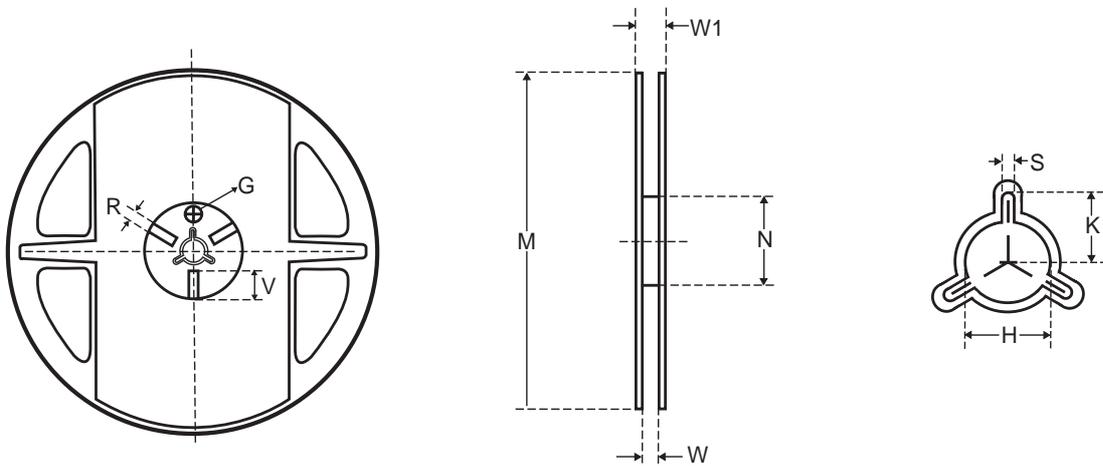
Carrier Tape & Reel Dimensions

SOT-23



Package	A0	B0	K0	D0	D1	E	E1	E2	P0	P1	P2	T
SOT-23	3.20 ± 0.10	3.00 ± 0.10	1.33 ± 0.10	1.00 + 0.25	1.50 + 0.10	8.00 +0.30 -0.10	1.75 ± 0.10	3.50 ± 0.05	4.00 ± 0.10	4.00 ± 0.10	2.00 ± 0.05	0.20 ± 0.02

UNIT : mm



Tape size	Reel Size	M	N	W	W1	H	K	S	G	R	V
8mm	178	178 ± 1	60 ± 1	9.0 ± 0.5	12.0 ± 0.5	13.5 ± 0.5	10.5	2.0 ± 0.5	10.0	5.0	18.0

UNIT : mm